

FDS6690S

30V N-Channel PowerTrench[®] SyncFET[™]

General Description

The FDS6690S is designed to replace a single SO-8 MOSFET and Schottky diode in synchronous DC:DC power supplies. This 30V MOSFET is designed to maximize power conversion efficiency, providing a low $R_{DS(ON)}$ and low gate charge. The FDS6690S includes an integrated Schottky diode using Fairchild's monolithic SyncFET technology. The performance of the FDS6690S as the low-side switch in a synchronous rectifier is close to the performance of the FDS6690A in parallel with a Schottky diode.

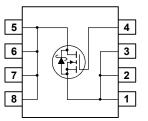
Applications

- DC/DC converter
- Motor drives



Features

- 10 A, 30 V. $R_{DS(ON)} = 0.016 \ \Omega \ @ V_{GS} = 10 \ V$ $R_{DS(ON)} = 0.025 \ \Omega \ @ V_{GS} = 4.5 \ V$
- Includes SyncFET Schottky diode
- Low gate charge (20 nC typical)
- High performance trench technology for extremely low
 R_{DS(ON)}
- High power and current handling capability



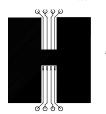
Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter			Ratings	Units
V _{DSS}	Drain-Source Voltage			30	V
V _{GSS}	Gate-Source Voltage			±20	V
I _D	Drain Current – Continuous (Note 1a)		(Note 1a)	10	A
		- Pulsed		50	
P _D	Power Dissipation for Single Operation (r		(Note 1a)	2.5	W
			(Note 1b)	1.2	
			(Note 1c)	1	
T _J , T _{STG}	Operating a	nd Storage Junction Tempe	erature Range	-55 to +150	°C
Therma	I Charact	eristics			
R _{0JA}	Thermal Resistance, Junction-to-Ambient (Note 1a)			50	°C/W
R _{eJC}	Thermal Resistance, Junction-to-Case (Note 1)			25	°C/W
Packag	e Marking	g and Ordering Ir	formation		·
Device Marking		Device	Reel Size	Tape width	Quantity
FDS6690S		FDS6690S	13"	12mm	2500 units

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Symbol	Parameter	Test Conditions	Min	Тур	Мах	Units
Off Chai	racteristics			1		
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 V, I_{D} = 1 mA$	30			V
<u>ΔBV_{DSS}</u> ΔTj	Breakdown Voltage Temperature Coefficient	I_D = 1 mA, Referenced to 25°C		23		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 V$, $V_{GS} = 0 V$			500	μA
I _{GSSF}	Gate-Body Leakage, Forward	V _{GS} = 20 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate–Body Leakage, Reverse	V _{GS} = -20 V V _{DS} = 0 V			-100	nA
On Char	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 1 \text{ mA}$	1	2.4	3	V
$\Delta V_{GS(th)}$ ΔT_J	Gate Threshold Voltage Temperature Coefficient	I_D = 1 mA, Referenced to 25°C		-6		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$V_{GS} = 10 V$, $I_D = 10 A$ $V_{GS} = 4.5 V$, $I_D = 8.5 A$ $V_{GS}=10 V$, $I_D = 10 A$, $T_J=125^{\circ}C$		13 20 19	16 25 26	mΩ
D(on)	On–State Drain Current	V _{GS} = 10 V, V _{DS} = 5 V	50			А
g _{FS}	Forward Transconductance	$V_{DS} = 15 V$, $I_{D} = 10 A$		26		S
Dvnamio	c Characteristics			1		
C _{iss}	Input Capacitance	$V_{DS} = 15 V$, $V_{GS} = 0 V$,		1233		pF
C _{oss}	Output Capacitance	f = 1.0 MHz		344		pF
C _{rss}	Reverse Transfer Capacitance			106		pF
Switchir	ng Characteristics (Note 2)			•		
t _{d(on)}	Turn–On Delay Time	V _{DS} = 15 V, I _D = 1 A,		8	16	ns
tr	Turn–On Rise Time	$V_{GS} = 10 V$, $R_{GEN} = 6 \Omega$		5	10	ns
t _{d(off)}	Turn–Off Delay Time			25	40	ns
t _f	Turn–Off Fall Time			11	20	ns
Qg	Total Gate Charge	V _{DS} = 15 V, I _D = 10 A,		11	16	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = 5 V$		5		nC
Q _{gd}	Gate–Drain Charge			4		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings				
Is	Maximum Continuous Drain-Source				3.5	А
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$, $I_S = 3.5 A$ (Note 2)		0.5	0.7	V
t _{rr}	Diode Reverse Recovery Time	I _F = 10A		17		nS
Q _{rr}	Diode Reverse Recovery Charge	$d_{iF}/d_t = 300 \text{ A}/\mu \text{s}$ (Note 3)		12.5		nC

the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 50°/W when mounted on a 1in² pad of 2 oz copper



b) 105°/W when mounted on a .04 in² pad of 2 oz copper c) 125°/W when mounted on a minimum pad.

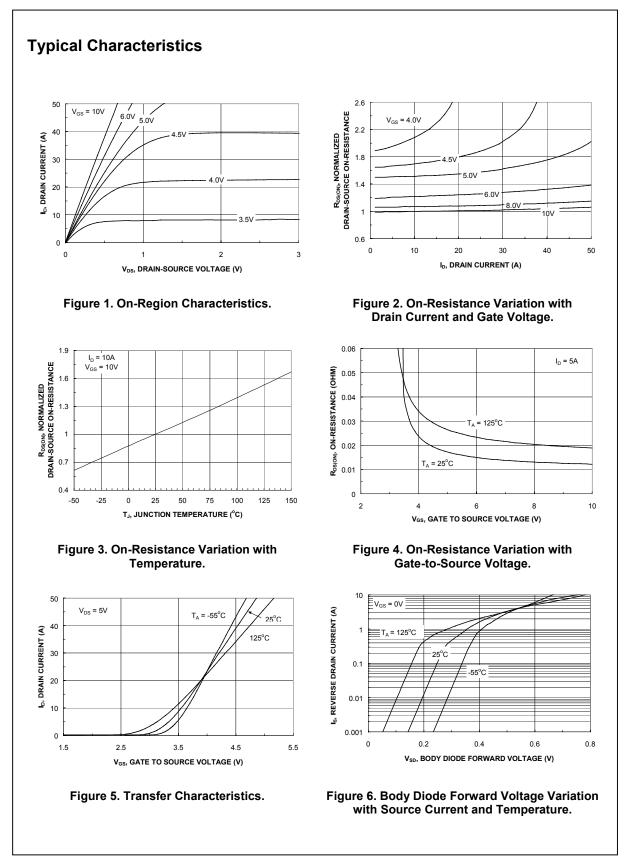
Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

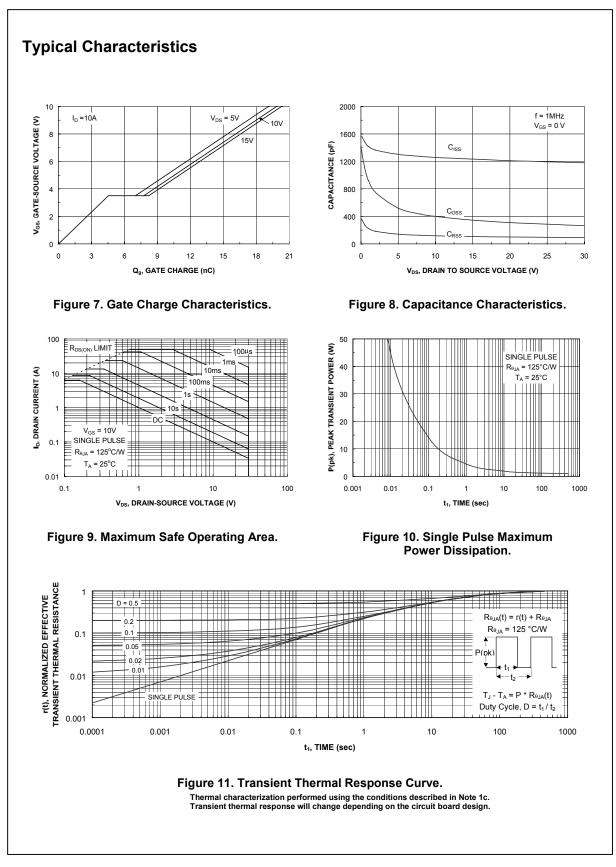
3. See "SyncFET Schottky body diode characteristics" below.

FDS6680S Rev C (W)

FDS6690S





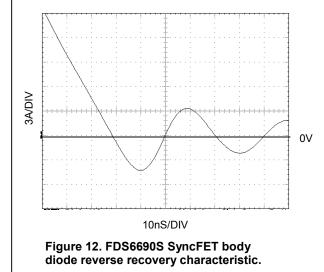


FDS6690S

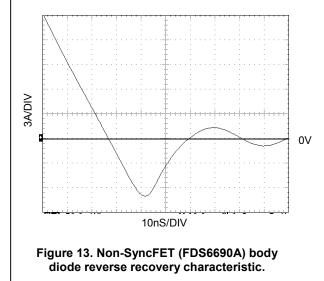
Typical Characteristics (continued)

SyncFET Schottky Body Diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 12 shows the reverse recovery characteristic of the FDS6690S.



For comparison purposes, Figure 13 shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET (FDS6690A).



Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

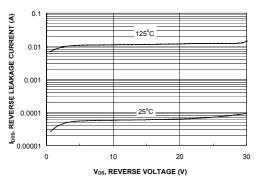
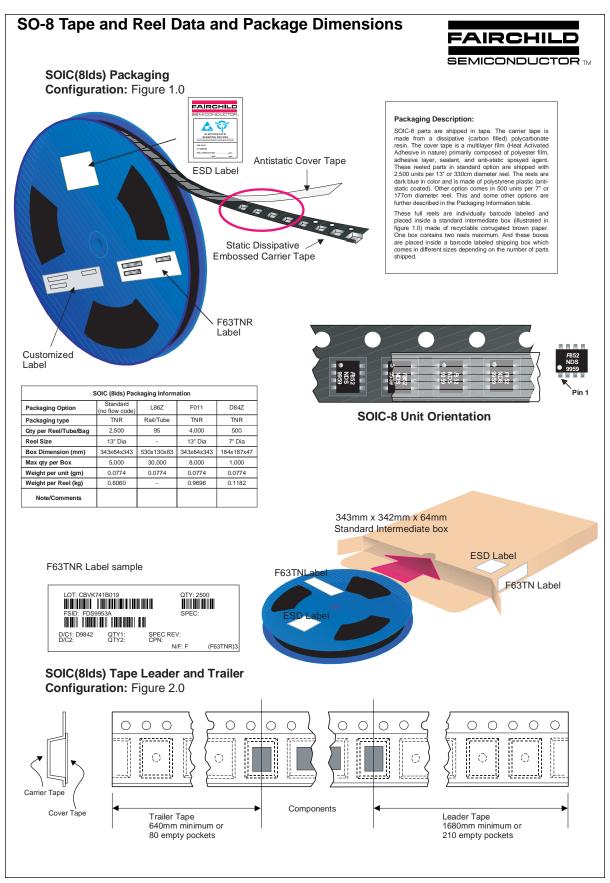
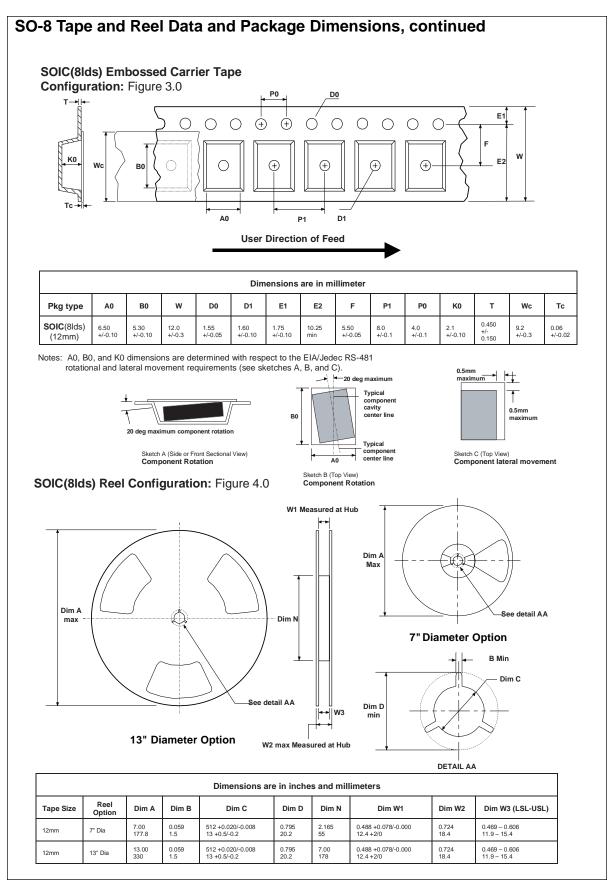


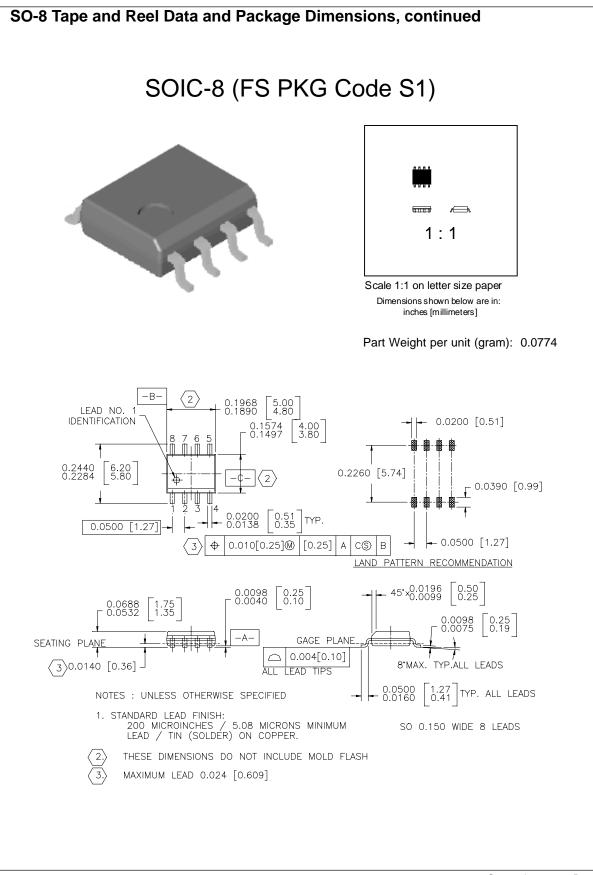
Figure 14. SyncFET body diode reverse leakage versus drain-source voltage and temperature.





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